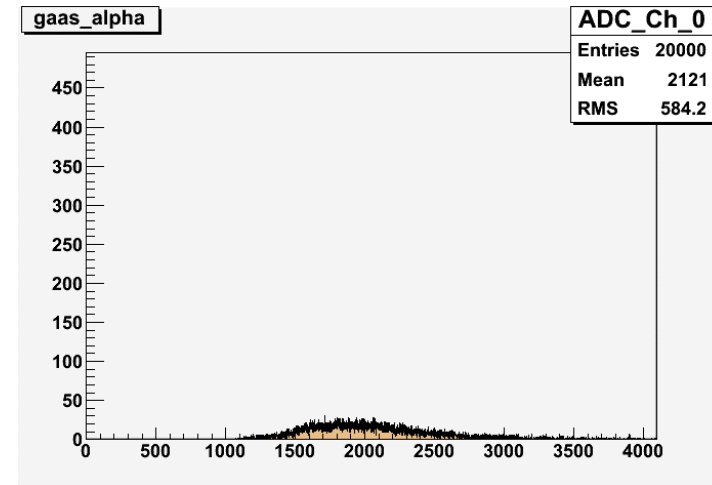
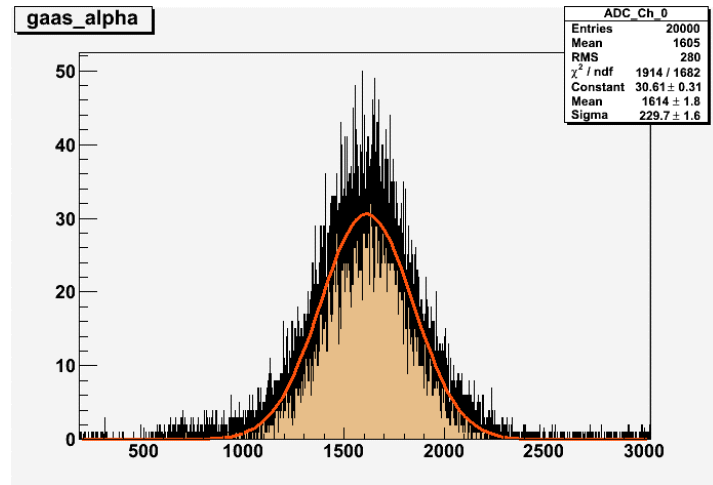




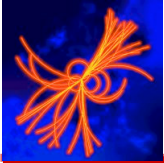
## GaAs sensor, irradiation with Am alpha source



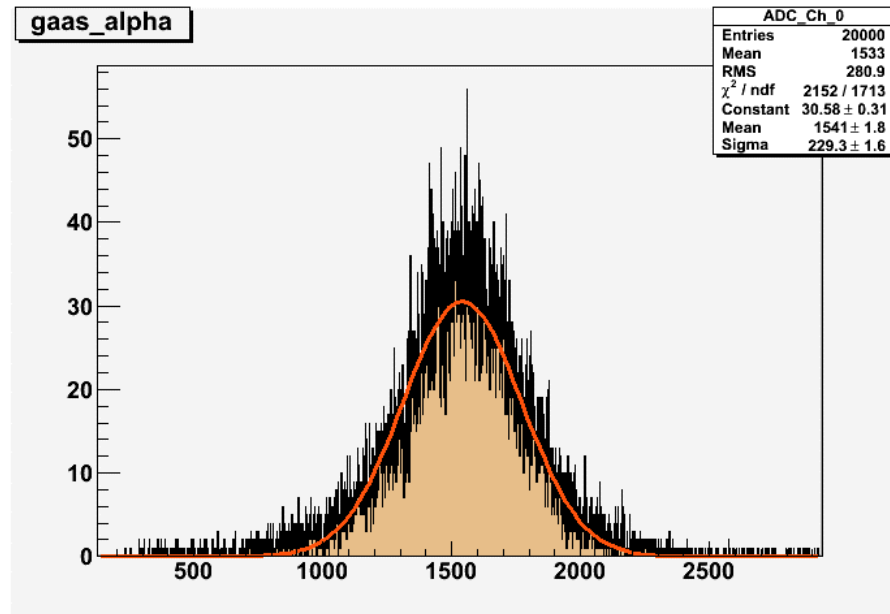
### Self trigger

-50 v bias on the same side as  
Am source  
20 dB attenuation

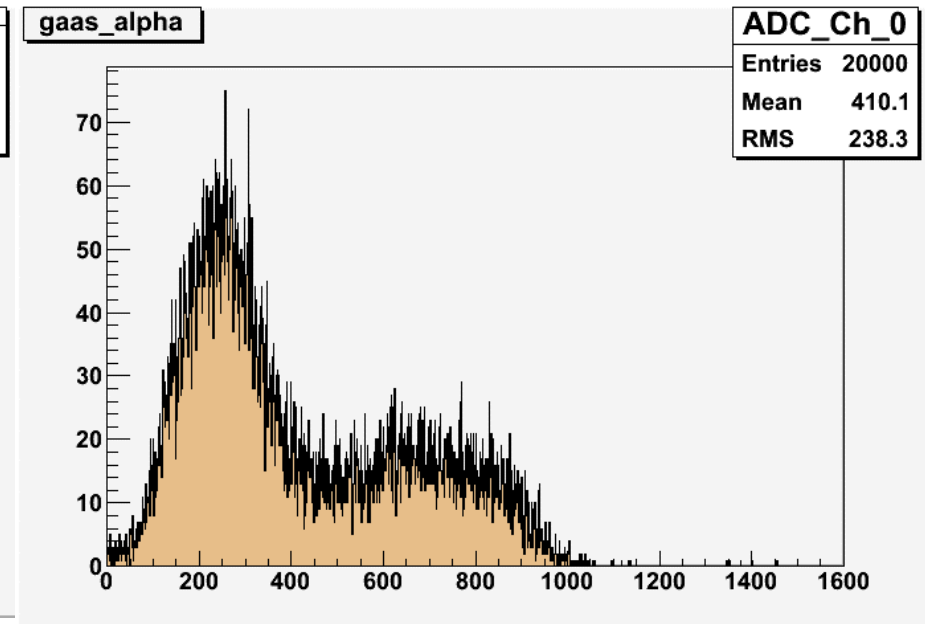
+50 v bias on the same side as  
Am source  
0 dB attenuation



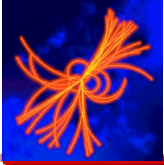
## Am source, other side



+50 v bias on the opposite side  
to Am source  
20 dB attenuation



-50 v bias on the opposite side to  
Am source  
0 dB attenuation



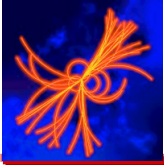
## Discussion

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Both sides show that signal due to electron transport is  $\sim 10$  times larger than to hole transport

This is explained in the paper G.I. Ayzenshtat et al.  
*GaAs resistor structures for X-ray imaging detectors*  
Nucl. Instr. and Meth. A 487 (2002) 96.

The explanation is that hole lifetime is much shorter than electron for this type of material (Cr - compensated semi-insulating GaAs)



## Conclusions

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Both pedestal and signal peaks are shifted. So if we use a fixed pedestal value in our calculations, we could introduce a small systematic error in the order of 1% (5% at highest occupancy).

Pedestal values from the spectra fits could be safely used

At higher occupancies the pedestal width is also increased

I didn't see any correlation between CR and landau and gauss sigma in the fits